

INTERFACE AND SWITCHING APPLICATION.

FEATURES

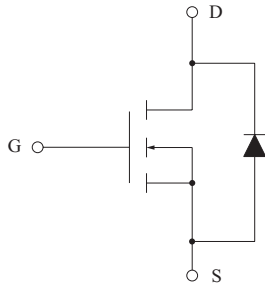
- High density cell design for low $R_{DS(ON)}$.
- Voltage controlled small signal switch.
- Rugged and reliable.
- High saturation current capability.

MAXIMUM RATING ($T_a=25^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage	V_{DSS}	60	V
Gate-Source Voltage	V_{GSS}	± 20	V
Drain Current	Continuous	I_D	500
	Pulsed(Note 1)	I_{DP}	2000
Drain Power Dissipation	P_D	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-55 ~ 150	$^\circ\text{C}$

Note 1) Pulse Width $\leq 10\mu\text{s}$, Duty Cycle $\leq 1\%$

EQUIVALENT CIRCUIT

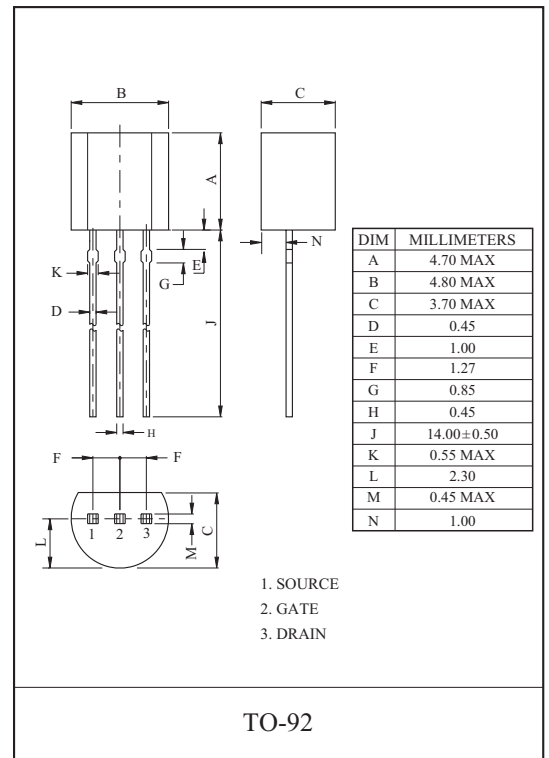


PLEASE HANDLE WITH CAUTION.

THIS TRANSISTOR IS ELECTROSTATIC SENSITIVE DEVICE.

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=10\mu\text{A}$	60	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=60V, V_{GS}=0V$	-	-	1	μA
Gate-Body Leakage, Forward	I_{GSSF}	$V_{GS}=20V, V_{DS}=0V$	-	-	100	nA
Gate-Body Leakage, Reverse	I_{GSSR}	$V_{GS}=-20V, V_{DS}=0V$	-	-	-100	nA



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ELECTRICAL CHARACTERISTICS (Ta=25 °C) ON CHARACTERISTICS (Note2)

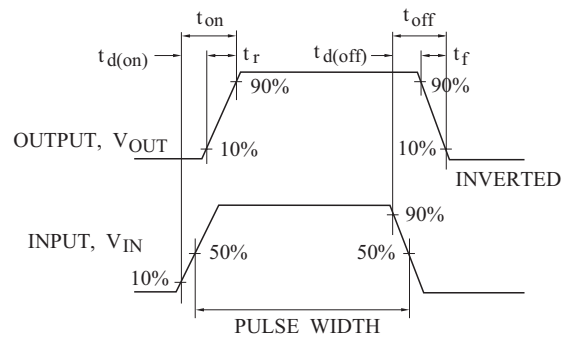
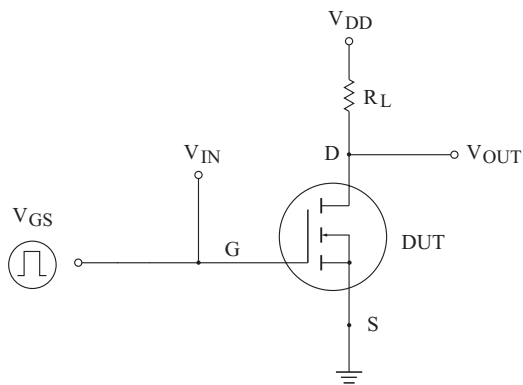
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Threshold Voltage	V_{th}	$V_{DS}=V_{GS}, I_D=250\mu A$	1.1	1.8	2.3	V
Drain-Source ON Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=500mA$	-	1.2	1.8	Ω
		$V_{GS}=5V, I_D=50mA$	-	1.5	2.1	
Drain-Source ON Voltage	$V_{DS(ON)}$	$V_{GS}=10V, I_D=500mA$	-	0.6	0.9	V
		$V_{GS}=5V, I_D=50mA$	-	0.075	0.105	
On State Drain Current	$I_{D(ON)}$	$V_{GS}=10V, V_{DS} \geq 2 V_{DS(ON)}$	500	-	-	mA
Forward Transconductance	g_{FS}	$V_{DS}=10V, I_D=500mA$	200	580	-	mS
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_S=200mA$ (Note1)	-	0.78	1.15	V

(Note 2) Pulse Test : Pulse Width $\leq 80\mu s$, Duty Cycle $\leq 1\%$

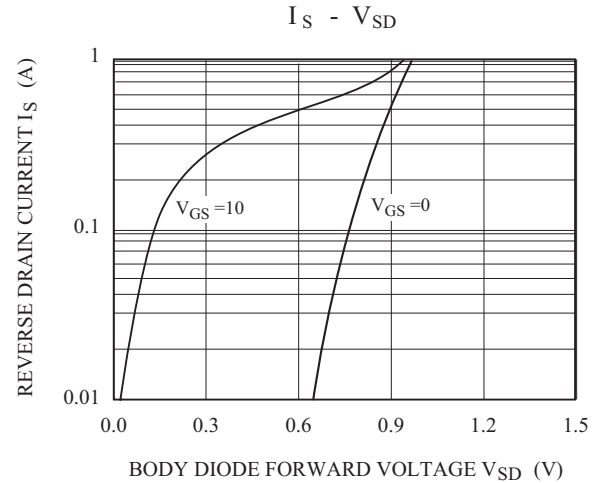
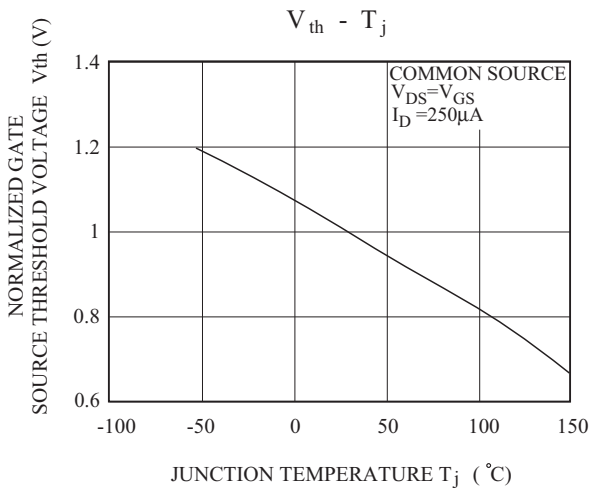
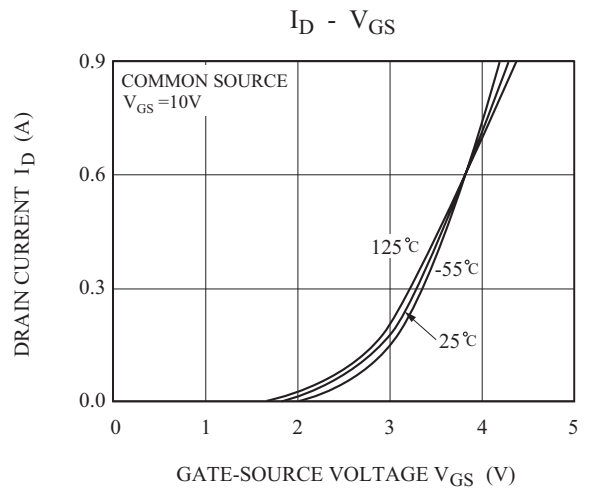
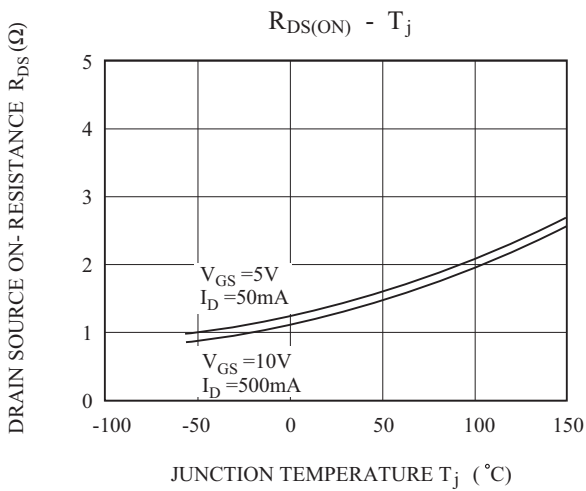
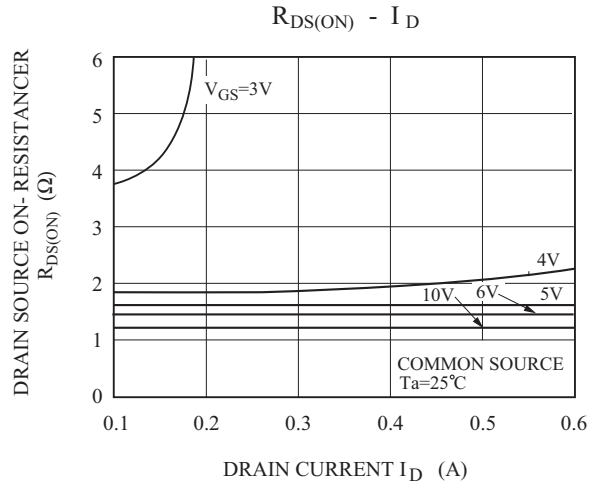
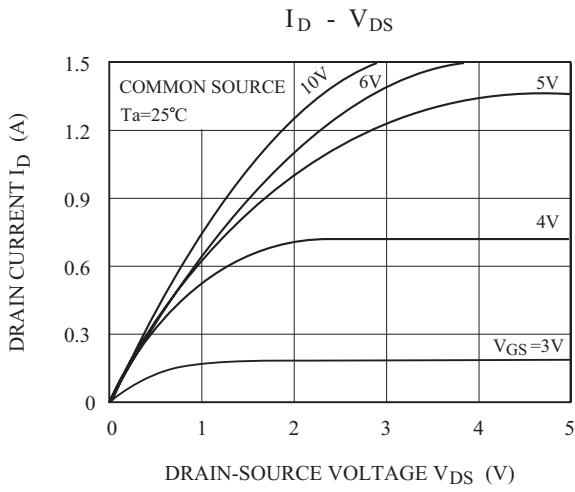
DYNAMIC CHARACTERISTICS

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT	
Input Capacitance	C_{iss}	$V_{DS}=25V, V_{GS}=0V, f=1MHz$	-	47.1	-	pF	
Reverse Transfer Capacitance	C_{rss}		-	3.5	-		
Output Capacitance	C_{oss}		-	8.8	-		
Switching Time	Turn-On Time	t_{on}	$V_{DD}=30V, R_L=155\Omega, I_D=190mA, V_{GS}=10V$	-	8.8	-	nS
	Turn-Off Time	t_{off}		-	14.8	-	

SWITCHING TIME TEST CIRCUIT

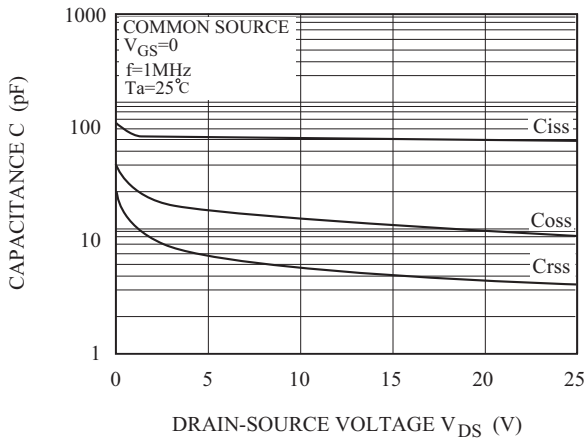


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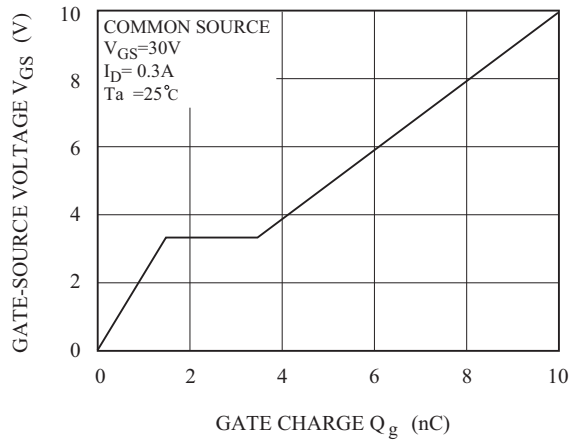


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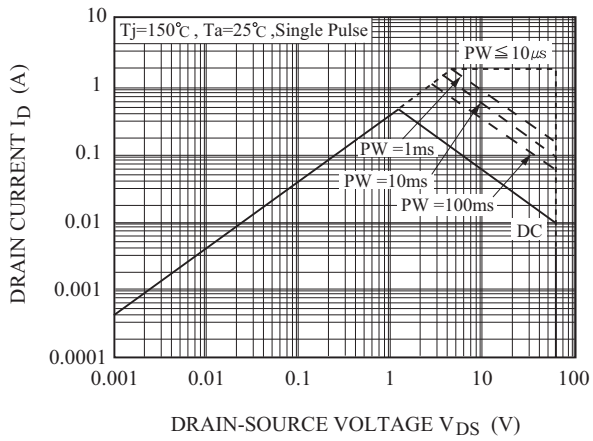
C - V_{DS}



V_{GS} - Q_g



SOA



P_D - T_a

